## Notice of References Cited

Application/Control No. 10/004,768

Applicant(s)/Patent Under Reexam Chen et al.

Examiner

James F. Hook

Art Unit 3752

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification <sup>2</sup>	
А	2,330,564	9/1943	Dyer	138	44
В	3,934,824	1/1976	Fitzhugh	138	42
С	5,094,271	3/1992	Fritz et al.	138	30
D	5,539,164	7/1996	Van Ruiten	138	30
E	5,728,981	3/1998	Van Ruiten	138	30
F	5,941,283	8/1999	Forte	138	26
G	6,073,656	6/2000	Chen et al.	138	30
н	6,119,728	9/2000	Seidel-Peschmann et al.	138	26
	6,125,890	10/2000	Cooper et al.	138	30 .
J	6,269,841	8/2001	Chen et al.	138	30
К	6,338,363	1/2002	Chen et al.	138	26
L					
м					

## FOREIGN PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>
ı	N					
(	0					
1	Р					
(	a					
ı	R					
	s ·					
1	т					

## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
v	
w	
x	

<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>&</sup>lt;sup>2</sup> Classifications may be U.S. or foreign.